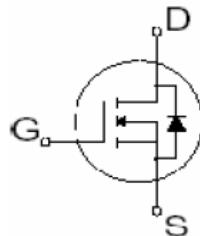




StarMOS^T Power MOSFET

- Extremely high dv/dt capability
- Low Gate Charge Qg results in Simple Drive Requirement
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability



V_{DSS} = 250V

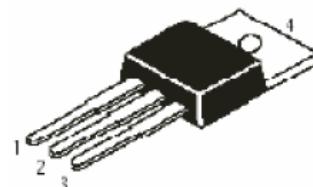
I_{D25} = 14A

R_{DSON} = 0.28 Ω

Description

StarMCS is a new generation of high voltage N-Channel enhancement mode power MOSFETs. This new technology minimises the JFET effect, increases packing density and reduces the on-resistance. StarMOS also achieves faster switching speeds through optimised gate layout with planar stripe DMOS technology.

TO-220



Pin1-Gate
Pin2-Drain
Pin3-Source

Application

- Switching application

Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @T _c =25°C	Continuous Drain Current,V _{Gs} @10V	14	A
I _D @T _c =100°C	Continuous Drain Current,V _{Gs} @10V	8.9	
I _{DM}	Pulsed Drain Current ①	56	
P _D @T _c =25°C	Power Dissipation	139	W
	Linear Derating Factor	1.1	W/C
V _{Gs}	Gate-to-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy ②	490	mJ
I _{AR}	Avalanche Current ①	14	A
E _{AR}	Repetitive Avalanche Energy ①	13.9	mJ
dv/dt	Peak Diode Recovery dv/dt ③	4.8	V/ns
I _J	Operating Junction and Storage Temperature Range	-55 to +150	°C
T _{STG}			
	Soldering Temperature, for 10 seconds	300(1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf.in(1.1N.m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R _{jc}	Junction-to-case	—	—	0.9	°C/W
R _{cs}	Case-to-Sink, Flat, Greased Surface	—	0.50	—	
R _{ja}	Junction-to-Ambient	—	—	62.5	



Typical Characteristics

Electrical Characteristics @ $T_J=25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	250	—	—	V	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp.Coefficient	—	0.28	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_{\text{D}}=250\mu\text{A}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-resistance	—	—	0.28	Ω	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=7\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$
g_{fs}	Forward Transconductance	—	8.65	—	S	$V_{\text{DS}}=40\text{V}, I_{\text{D}}=7\text{A}$
I_{DS}	Drain-to-Source Leakage current	—	—	10	μA	$V_{\text{DS}}=250\text{V}, V_{\text{GS}}=0\text{V}$
		—	—	100		$V_{\text{DS}}=200\text{V}, V_{\text{GS}}=0\text{V}, T_J=150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward leakage	—	—	100	nA	$V_{\text{GS}}=30\text{V}$
	Gate-to-Source Reverse leakage	—	—	-100		$V_{\text{GS}}=-30\text{V}$
Q_g	Total Gate Charge	—	46	61	nC	$I_{\text{D}}=14\text{A}$
Q_{gs}	Gate-to-Source charge	—	9.3	—		$V_{\text{DS}}=200\text{V}$
Q_{gd}	Gate-to-Drain("Miller") charge	—	19.5	—		$V_{\text{GS}}=10\text{V}$
$t_{\text{d(on)}}$	Turn-on Delay Time	—	17	50	nS	$V_{\text{DD}}=125\text{V}$
t_{r}	Rise Time	—	17	50		$I_{\text{D}}=14\text{A}$
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	74	160		$R_{\text{G}}=9.1\Omega$
t_{f}	Fall Time	—	32	80		
L_{D}	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm(0.25in.) from package and center of die contact
L_{S}	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	1230	1600	pF	$V_{\text{GS}}=0\text{V}$
C_{oss}	Output Capacitance	—	180	65		$V_{\text{DS}}=25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	23	28		$f=1.0\text{MHz}$

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_{s}	Continuous Source Current (Body Diode)	—	—	14	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Sourcc Current (Body Diode) ①	—	—	56	A	
V_{SD}	Diode Forward Voltage	—	—	1.5	V	$T_J=25^\circ\text{C}, I_{\text{S}}=14\text{A}, V_{\text{GS}}=0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	215	—	nS	$T_J=25^\circ\text{C}, I_F=14\text{A}$
Q_{rr}	Reverse Recovery Charge	—	1.59	—	μC	$dI/dt=100\text{A}/\mu\text{s}$ ④
t_{ton}	Forward Turn-on Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_s + L_d$)				

Notes:

- ① Repetitive rating;pulse width limited by max.junction temperature(see figure 11)
- ② $L = 4\text{mH}$, $I_{AS} = 14\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 270$, Starting T.I = 25°C
- ③ $I_{SD} \leq 14\text{A}, dI/dt \leq 250\text{A}/\mu\text{s}, V_{DD} \leq V_{(\text{BR})\text{DSS}}, T_J \leq 25^\circ\text{C}$
- ④ Pulse width $\leq 300\ \mu\text{s}$; duty cycle $\leq 2\%$